SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

**DGG OR DGV PACKAGE** 

- Member of the Texas Instruments Widebus™ Family
- TI-OPC™ Circuitry Limits Ringing on **Unevenly Loaded Backplanes**
- **OEC™** Circuitry Improves Signal Integrity and Reduces Electromagnetic Interference
- **Bidirectional Interface Between GTLP** Signal Levels and LVTTL Logic Levels
- Split LVTTL Port Provides a Feedback Path for Control and Diagnostics Monitoring
- LVTTL Interfaces Are 5-V Tolerant
- **High-Drive GTLP Open-Drain Outputs** (100 mA)
- LVTTL Outputs (-24 mA/24 mA)
- Variable Edge-Rate Control (ERC) Input Selects GTLP Rise and Fall Times for **Optimal Data-Transfer Rate and Signal** Integrity in Distributed Loads
- Ioff, Power-Up 3-State, and BIAS VCC **Support Live Insertion**
- Distributed V<sub>CC</sub> and GND Pins Minimize **High-Speed Switching Noise**
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- **ESD Protection Exceeds JESD 22** 
  - 2000-V Human-Body Model (A114-A)
  - 1000-V Charged-Device Model (C101)

#### (TOP VIEW) IMODE1 48 ∏ IMODE0 47 BIAS VCC AI1 2 AO1 [] 3 46 🛮 B1 GND 45 | GND 114 44 **∏** OEAB Al2 | 15 AO2 6 43 T B2 42 TERC V<sub>CC</sub> []7 41 OEAB AI3 AO3 [] 9 40 ∏ B3 GND ∏10 39 | GND AI4 [] 11 38 CLKAB/LEAB AO4 37 ∏ B4 12 AO5 ∏ 13 36 ∏ B5 AI5 35 CLKBA/LEBA 14 GND 15 34 ∏ GND AO6 16 33 🛮 B6 Al6 17 32 | OEBA V<sub>CC</sub> 18 31 V<sub>CC</sub> AO7 П 19 30 **∏** B7 29 LOOPBACK 20 GND 21 28 | GND AO8 1 22 27 | B8 AI8 23 26 V<sub>RFF</sub> 25 OMODE1 OMODE0 I 24

#### description

The SN74GTLP2033 is a high-drive, 8-bit, three-wire registered transceiver that provides inverted LVTTL-to-GTLP and GTLP-to-LVTTL signal-level translation. The device allows for transparent, latched, and flip-flop modes of data transfer with separate LVTTL input and LVTTL output pins, which provides a feedback path for control and diagnostics monitoring, the same functionality as the SN74FB2033. The device provides a high-speed interface between cards operating at LVTTL logic levels and a backplane operating at GTLP signal levels. High-speed (about three times faster than standard LVTTL or TTL) backplane operation is a direct result of GTLP's reduced output swing (<1 V), reduced input threshold levels, improved differential input, OEC™ circuitry, and TI-OPC™ circuitry. Improved GTLP OEC and TI-OPC circuits minimize bus-settling time and have been designed and tested using several backplane models. The high drive allows incident-wave switching in heavily loaded backplanes with equivalent load impedance down to 11  $\Omega$ .



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

### description (continued)

GTLP is the Texas Instruments derivative of the Gunning Transceiver Logic (GTL) JEDEC standard JESD 8-3. The ac specification of the SN74GTLP2033 is given only at the preferred higher noise-margin GTLP, but the user has the flexibility of using this device at either GTL ( $V_{TT} = 1.2 \text{ V}$  and  $V_{REF} = 0.8 \text{ V}$ ) or GTLP ( $V_{TT} = 1.5 \text{ V}$  and  $V_{REF} = 1 \text{ V}$ ) signal levels. For information on using GTLP devices in FB+/BTL applications, refer to TI application reports, *Texas Instruments GTLP Frequently Asked Questions*, literature number SCEA019, and *GTLP in BTL Applications*, literature number SCEA017.

Normally, the B port operates at GTLP signal levels. The A-port and control inputs operate at LVTTL logic levels, but are 5-V tolerant and can be directly driven by TTL or 5-V CMOS devices. V<sub>REF</sub> is the B-port differential input reference voltage.

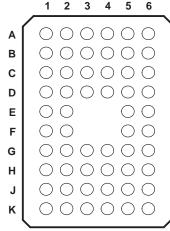
This device is fully specified for live-insertion applications using  $I_{off}$ , power-up 3-state, and BIAS  $V_{CC}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict. The BIAS  $V_{CC}$  circuitry precharges and preconditions the B-port input/output connections, preventing disturbance of active data on the backplane during card insertion or removal, and permits true live-insertion capability.

This GTLP device features TI-OPC circuitry, which actively limits overshoot caused by improperly terminated backplanes, unevenly distributed cards, or empty slots during low-to-high signal transitions. This improves signal integrity, which allows adequate noise margin to be maintained at higher frequencies.

High-drive GTLP backplane interface devices feature adjustable edge-rate control (ERC). Changing the ERC input voltage between low and high adjusts the B-port output rise and fall times. This allows the designer to optimize system data-transfer rate and signal integrity to the backplane load.

When  $V_{CC}$  is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V,  $\overline{OEAB}$  should be tied to  $V_{CC}$  through a pullup resistor and OEAB and OEBA should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

# GQL PACKAGE (TOP VIEW)



#### terminal assignments

	1	2	3	4	5	6
Α	IMODE1	NC	NC	NC	NC	IMODE0
В	AO1	Al1	GND	GND	BIAS V <sub>CC</sub>	B1
С	AO2	Al2	VCC	ERC	OEAB	B2
D	AO3	Al3	GND	GND	OEAB	В3
Е	AO4	Al4			CLKAB/LEAB	B4
F	AO5	AI5			CLKBA/LEBA	B5
G	AO6	Al6	GND	GND	OEBA	B6
Н	AO7	AI7	VCC	Vcc	LOOPBACK	B7
J	AO8	Al8	GND	GND	V <sub>REF</sub>	B8
K	OMODE0	NC	NC	NC	NC	OMODE1

NC = No internal connection



SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

#### ORDERING INFORMATION

TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	TSSOP – DGG	Tape and reel	SN74GTLP2033DGGR	GTLP2033
	TVSOP - DGV	Tape and reel	SN74GTLP2033DGVR	GT2033
	VFBGA – GQL	Tape and reel	SN74GTLP2033GQLR	GR033

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

#### functional description

The SN74GTLP2033 is a high-drive (100 mA), 8-bit, three-wire registered transceiver containing D-type latches and D-type flip-flops for data-path operation in the transparent, latched, or flip-flop modes. Data transmission is complementary, with inverted AI data going to the B port and inverted B data going to AO. The split LVTTL AI and AO provides a feedback path for control and diagnostics monitoring.

The logic element for data flow in each direction is configured by two mode (IMODE1 and IMODE0 for B to A, OMODE1 and OMODE0 for A to B) inputs as a buffer, D-type flip-flop, or D-type latch. When configured in the buffer mode, the inverted input data appears at the output port. In the flip-flop mode, data is stored on the rising edge of the appropriate clock (CLKAB/LEAB or CLKBA/LEBA) input. In the latch mode, the clock inputs serve as active-high transparent latch enables.

Data flow in the B-to-A direction, regardless of the logic element selected, is further controlled by the LOOPBACK input. When LOOPBACK is low, B-port data is the B-to-A input. When LOOPBACK is high, the output of the selected A-to-B logic element (prior to inversion) is the B-to-A input.

The AO enable/disable control is provided by OEBA. When OEBA is low or when  $V_{CC}$  is less than 1.5 V, AO is in the high-impedance state. When OEBA is high, AO is active (high or low logic levels).

The B port is controlled by OEAB and  $\overline{\text{OEAB}}$ . If OEAB is low,  $\overline{\text{OEAB}}$  is high, or  $V_{CC}$  is less than 1.5 V, the B port is inactive. If OEAB is high and  $\overline{\text{OEAB}}$  is low, the B port is active.

The A-to-B and B-to-A logic elements are active, regardless of the state of their associated outputs. The logic elements can enter new data (in flip-flop and latch modes) or retain previously stored data while the associated outputs are in the high-impedance (AO) or inactive (B port) states.



SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

#### **Function Tables**

### FUNCTION/MODE

				INPUTS				CUITDUIT	MODE	
OEBA	OEAB	OEAB	OMODE1	OMODE0	IMODE1	IMODE0	LOOPBACK	OUTPUT	MODE	
L	L	Χ	Х	Х	Х	Х	X	7	la alatha	
L	Χ	Н	Χ	Χ	Χ	Χ	X	Z	Isolation	
Х	Н	L	L	L	Х	Х	X		Buffer	
Х	Н	L	L	Н	Χ	Χ	X	Inverted AI to B	Flip-flop	
Х	Н	L	Н	Χ	Χ	Χ	X		Latch	
Н	L	Χ	Х	Х	L	L	L	leavested B to AO	D. #	
Н	Χ	Н	Χ	Χ	L	L	L	Inverted B to AO	Buffer	
Н	L	Χ	Х	Х	L	Н	L	leavested B to AO	El'a dan	
Н	Χ	Н	Χ	Χ	L	Н	L	Inverted B to AO	Flip-flop	
Н	L	Χ	Х	Х	Н	Х	L	Learning I B to A O	Latab	
Н	Χ	Н	Χ	Χ	Н	Χ	L	Inverted B to AO	Latch	
Н	L	Χ	Χ	Χ	L	L	Н	A14- A0	D. #	
Н	Χ	Н	Χ	Χ	L	L	Н	AI to AO	Buffer	
Н	L	Χ	Χ	Χ	L	Н	Н	A1 40 A O	Flip floor	
Н	Χ	Н	Χ	Χ	L	Н	Н	AI to AO	Flip-flop	
Н	L	X	Х	Х	Н	Х	Н	Al to AO	Latah	
Н	Χ	Н	Х	Χ	Н	X	Н	AI to AO	Latch	
Н	Н	L	Х	Х	Х	Х	L	Inverted AI to B, Inverted B to AO	Transparent with feedback path	

## **ENABLE/DISABLE**

	INPUTS	OUTI	PUTS					
OEBA	OEAB	OEAB	AO	В				
L	Χ	Χ	Z					
Н	Χ	Χ	Active					
Х	L	L		Z				
Х	L	Н		Z				
Х	Н	L		Active				
Х	Н	Н		Z				

#### **BUFFER**

INPUT	OUTPUT
L	Н
Н	L

#### LATCH

INPU	OUTDUT	
CLK/LE	OUTPUT	
Н	L	Н
Н	Н	L
L	X	Q <sub>0</sub>



# **SN74GTLP2033** 8-BIT LVTTL-TO-GTLP ADJUSTABLE-EDGE-RATE REGISTERED TRANSCEIVER WITH SPLIT LYTTL PORT AND FEEDBACK PATH SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

## **Function Tables (Continued)**

### LOOPBACK

LOOPBACK	Q†
L	B port
Н	Point P‡

<sup>†</sup>Q is the input to the B-to-A logic element.

#### **SELECT**

INPUTS MODE1 MODE0		SELECTED LOGIC
		ELEMENT
L	L	Buffer
L	Н	Flip-flop
Н	Χ	Latch

#### **FLIP-FLOP**

INPU'	TS	OUTDUT		
CLK/LE	DATA	OUTPUT		
L	Х	Q <sub>0</sub>		
1	L	Н		
1	Н	L		

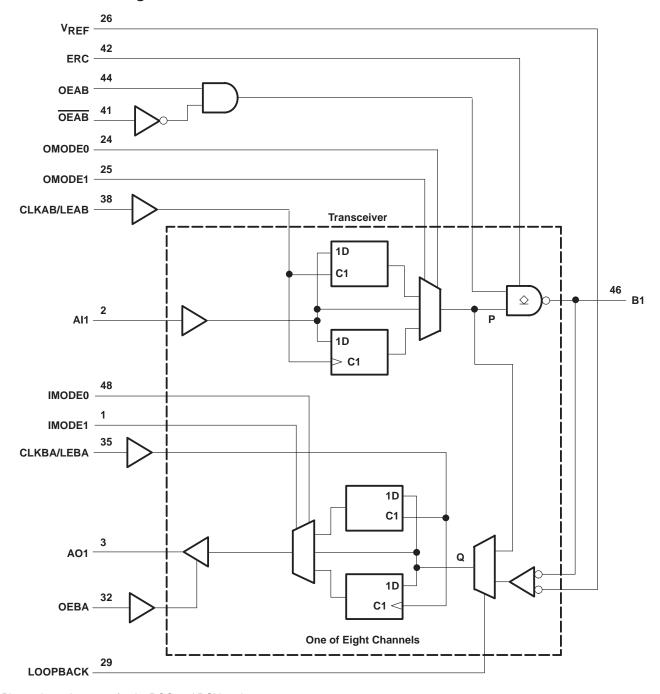
#### **B-PORT EDGE-RATE CONTROL (ERC)**

INPUT ERC	OUTPUT B-PORT
LOGIC LEVEL	EDGE RATE
Н	Slow
L	Fast

<sup>‡</sup>P is the output of the A-to-B logic element (see functional block diagram).

SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

## functional block diagram



Pin numbers shown are for the DGG and DGV packages.



SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, $V_{CC}$ and BIAS $V_{CC}$	.5 V to 7 V
Voltage range applied to any output in the high-impedance or power-off state, V <sub>O</sub>	
(see Note 1): AO port	
B port	V to 4.6 V
Current into any output in the low state, IO: AO port	48 mA
B port	200 mA
Current into any A-port output in the high state, IO (see Note 2)	48 mA
Continuous current through each V <sub>CC</sub> or GND	
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 3): DGG package	70°C/W
DGV package	
GQL package	
Storage temperature range, T <sub>stq</sub> –65°C	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

- 2. This current flows only when the output is in the high state and  $V_O > V_{CC}$ .
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.



SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

## recommended operating conditions (see Notes 4 through 7)

			MIN	NOM	MAX	UNIT	
V <sub>CC</sub> , BIAS V <sub>CC</sub>	Supply voltage		3.15	3.3	3.45	V	
.,		GTL	1.14	1.2	1.26	V	
VTT	Termination voltage	GTLP	1.35	1.5	1.65		
V	Defended welling	GTL	0.74	0.8	0.87	.,	
$V_{REF}$	Reference voltage	GTLP	0.87	1	1.1	V	
VI	Lament and the ma	B port			VTT	V	
	Input voltage	Except B port and VREF		Vcc	5.5		
VIH	High-level input voltage	B port	V <sub>REF</sub> +0.05			V	
		Except B port	2				
V		B port			V <sub>REF</sub> -0.05	.,	
VIL	Low-level input voltage	Except B port			0.8	V	
l <sub>IK</sub>	Input clamp current				-18	mA	
loh	High-level output current	AO			-24	mA	
		AO			24		
lOL	Low-level output current	B port			100	mA	
Δt/Δν	Input transition rise or fall rate	Outputs enabled			10	ns/V	
Δt/ΔV <sub>CC</sub>	Power-up ramp rate		20			μs/V	
T <sub>A</sub>	Operating free-air temperature		-40		85	°C	

- NOTES: 4. All unused control and B-port inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.
  - 5. Proper connection sequence for use of the B-port I/O precharge feature is GND and BIAS V<sub>CC</sub> = 3.3 V first, I/O second, and V<sub>CC</sub> = 3.3 V last, because the BIAS V<sub>CC</sub> precharge circuitry is disabled when any V<sub>CC</sub> pin is connected. The control and V<sub>REF</sub> inputs can be connected anytime, but normally are connected during the I/O stage. If B-port precharge is not required, any connection sequence is acceptable but, generally, GND is connected first.
  - 6. V<sub>TT</sub> and R<sub>TT</sub> can be adjusted to accommodate backplane impedances if the dc recommended I<sub>OL</sub> ratings are not exceeded.
  - 7. V<sub>REF</sub> can be adjusted to optimize noise margins, but normally is two-thirds V<sub>TT</sub>. TI-OPC circuitry is enabled in the A-to-B direction and is activated when V<sub>TT</sub> > 0.7 V above V<sub>REF</sub>. If operated in the A-to-B direction, V<sub>REF</sub> should be set to within 0.6 V of V<sub>TT</sub> to minimize current drain.



SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

# electrical characteristics over recommended operating free-air temperature range for GTLP (unless otherwise noted)

	PARAMETER	TEST CONDITIONS		MIN	TYP†	MAX	UNIT		
٧ıK		$V_{CC} = 3.15 V,$	I <sub>I</sub> = -18 mA			-1.2	V		
		$V_{CC} = 3.15 \text{ V to } 3.45 \text{ V},$	I <sub>OH</sub> = -100 μA	V <sub>CC</sub> -0.2					
$V_{OH}$	AO	V 245 V	$I_{OH} = -12 \text{ mA}$	2.4			V		
		V <sub>CC</sub> = 3.15 V	$I_{OH} = -24 \text{ mA}$	2					
		$V_{CC} = 3.15 \text{ V to } 3.45 \text{ V},$	$I_{OL} = 100 \mu\text{A}$			0.2			
	AO	Van - 2 15 V	$I_{OL} = 12 \text{ mA}$			0.4			
\/a:		V <sub>CC</sub> = 3.15 V	$I_{OL} = 24 \text{ mA}$			0.5	V		
VOL			$I_{OL} = 10 \text{ mA}$			0.2	V		
	B port	V <sub>CC</sub> = 3.15 V	$I_{OL} = 64 \text{ mA}$			0.4			
			$I_{OL} = 100 \text{ mA}$			0.55			
ı <sub>l</sub> ‡	Al and control inputs	V <sub>CC</sub> = 3.45 V,	V <sub>I</sub> = 0 or 5.5 V			±10	μΑ		
. +	AO	V <sub>CC</sub> = 3.45 V,	$V_0 = 0 \text{ to } 5.5 \text{ V}$			±10			
loz‡	B port	$V_{CC}$ = 3.45 V, $V_{REF}$ within 0.6 V of $V_{TT}$ ,	V <sub>O</sub> = 0 to 2.3 V			±10	μΑ		
		V <sub>CC</sub> = 3.45 V, I <sub>O</sub> = 0,	Outputs high			40			
ICC	AO or B port	V <sub>I</sub> (A-port or control input) = V <sub>CC</sub> or GND,	Outputs low		40		mA		
		$V_I$ (B port) = $V_{TT}$ or GND	Outputs disabled			40			
ΔICC§		V <sub>CC</sub> = 3.45 V, One AI or control input at V <sub>C</sub> . Other AI or control inputs at V <sub>CC</sub> or GND	C - 0.6 V,			1.5	mA		
_	AI	V 0.45V 0			3.5	4.5			
Ci	Control inputs	V <sub>I</sub> = 3.15 V or U	$V_{\rm I} = 3.15  \rm V  or  0$				pF		
Co	AO	V <sub>O</sub> = 3.15 V or 0			5	6	pF		
C <sub>io</sub>	B port	V <sub>O</sub> = 1.5 V or 0	_		8.5	10	pF		

<sup>†</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

### hot-insertion specifications for A port over recommended operating free-air temperature range

PARAMETER		TEST CONDITIONS						
loff	$V_{CC} = 0$ ,	$V_I$ or $V_O = 0$ to 5.5 $V$			10	μΑ		
lozpu	$V_{CC} = 0 \text{ to } 1.5 \text{ V},$	$V_0 = 0.5 \text{ V to 3 V},$	OEBA = V <sub>CC</sub>		±30	μΑ		
lozpd	$V_{CC} = 1.5 \text{ V to } 0,$	$V_0 = 0.5 \text{ V to 3 V},$	OEBA = V <sub>CC</sub>		±30	μΑ		

### live-insertion specifications for B port over recommended operating free-air temperature range

PARAMETER		TEST CONDITIONS								
l <sub>off</sub>	$V_{CC} = 0$ ,	BIAS $V_{CC} = 0$ ,	$V_I$ or $V_O = 0$ to 1.5 $V$		10	μΑ				
lozpu	$V_{CC} = 0$ to 1.5 V, BIAS V	$CC = 0$ to 1.5 V, BIAS $V_{CC} = 0$ , $V_{O} = 0.5$ V to 1.5 V, $\overline{OEAB} = 0$ and $OEAB = V_{CC}$								
lozpd	V <sub>CC</sub> = 1.5 V to 0, BIAS \		±30	μΑ						
Icc	V <sub>CC</sub> = 0 to 3.15 V	DIA 0 1/2 0 45 1/4	V (D mart) 0.15 4.5 V		5	mA				
(BIAS V <sub>CC</sub> )	V <sub>CC</sub> = 3.15 V to 3.45 V	BIAS $V_{CC} = 3.15 \text{ V to } 3.45 \text{ V},$		10	μΑ					
Vo	$V_{CC} = 0$ ,	BIAS $V_{CC} = 3.3 V$ ,	IO = 0	0.95	1.05	V				
lo	$V_{CC} = 0$ ,	BIAS $V_{CC} = 3.15 \text{ V to } 3.45 \text{ V}$ ,	V <sub>O</sub> (B port) = 0.6 V	-1	·	μΑ				



<sup>‡</sup> For I/O ports, the parameter IOZ includes the input leakage current.

<sup>§</sup> This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

timing requirements over recommended ranges of supply voltage and operating free-air temperature,  $V_{TT}$  = 1.5 V and  $V_{REF}$  = 1 V for GTLP (unless otherwise noted)

			MIN	MAX	UNIT
fclock	Clock frequency			175	MHz
t <sub>W</sub>	Pulse duration	CLKAB/LEAB or CLKBA/LEBA	2.8		ns
		Al before CLKAB↑	1.1		
t <sub>su</sub> Se		Al before CLKBA↑	1.4		
		B before CLKBA↑	1		
	Setup time	Al before LEAB↓	1.6		ns
		Al before LEBA↓	2.1		
		B before LEBA↓	2.2		
		Al after CLKAB↑	0.3		
		Al after CLKBA↑	0.2		
		B after CLKBA↑	0.6		
th	Hold time	Al after LEAB↓	0.3		ns
		Al after LEBA↓	0		
		B after LEBA↓	0		



SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $V_{TT}$ = 1.5 V and $V_{REF}$ = 1 V for GTLP (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATET	MIN	TYP‡ MAX	UNIT	
f <sub>max</sub>				175		MHz	
tPLH	Al	_	-	3	7.4		
<sup>t</sup> PHL	(buffer)	В	Slow	3	7.1	ns	
t <sub>PLH</sub>	Al		<b>-</b> .	2	5.9		
<sup>t</sup> PHL	(buffer)	В	Fast	2	5.8	ns	
<sup>t</sup> PLH	В	100		1	5.7		
<sup>t</sup> PHL	(buffer)	AO	_	1	5	ns	
<sup>t</sup> PLH	LEAB		Class	4.2	8.6	20	
<sup>t</sup> PHL	(latch mode)	В	Slow	3.2	7.7	ns	
<sup>t</sup> PLH	LEAB	В	Fast	3.2	7.6	no	
<sup>t</sup> PHL	(latch mode)	В	rasi	2.8	6.7	ns	
<sup>t</sup> PLH	LEAB	AO		2	7	no	
<sup>t</sup> PHL	(latch mode)	AO	_	1.8	6.3	ns	
<sup>t</sup> PLH	LEBA	AO		1	5.7	nc	
<sup>t</sup> PHL	(latch mode)	AO	_	1	4.7	ns	
<sup>t</sup> PLH	OEAB	В	Slow	3.8	7.5	ns	
<sup>t</sup> PHL	OLAB	Ь	Slow	3.1	7	115	
t <sub>PLH</sub>	OEAB	В	Fast	2.5	6	ns	
<sup>t</sup> PHL	OLAB	Ь	FaSi	2.5	6	115	
t <sub>PLH</sub>	<del>OEAB</del>	В	Slow	3.5	7.5	ns	
<sup>t</sup> PHL	OLAB	Ь	Slow	3	7.2	115	
t <sub>PLH</sub>	<del>OEAB</del>	В	Fast	2.5	6	ns	
<sup>t</sup> PHL	OLAB	Ь	rast	2.5	6	113	
<sup>t</sup> PZH	OEBA	AO	_	1	4.7	ns	
t <sub>PZL</sub>	OLDA	٨٥	_	1	3.4	113	
<sup>t</sup> PHZ	OEBA	AO		1	5.2	ns	
<sup>t</sup> PLZ	OLDA	٨٥	_	1	4.9	113	
<sup>t</sup> PLH	CLKAB	В	Slow	4.4	8.8	ns	
<sup>t</sup> PHL	(flip-flop mode)	5	Glow	3.6	8.1	113	
<sup>t</sup> PLH	CLKAB	В	Fast	3.2	7.2	ns	
<sup>t</sup> PHL	(flip-flop mode)	5	1 431	3.1	6.9	110	
t <sub>PLH</sub>	CLKAB	AO	_	2	6.9	ns	
t <sub>PHL</sub>	(flip-flop mode)	710		1.8	6.4	110	
t <sub>PLH</sub>	CLKBA	AO	_	1	5.6	ns	
<sup>t</sup> PHL	(flip-flop mode)	710		1	4.9	110	
<sup>t</sup> PLH	OMODE	В	Slow	3.8	8.7	ns	
<sup>t</sup> PHL	0.110BE		Clow	3.2	8.2	110	
<sup>t</sup> PLH	OMODE	В	Fast	2.7	7.2	ns	
<sup>t</sup> PHL	O.MODE		1 431	2.7	7.2		
t <sub>PLH</sub>	IMODE	AO	_ 1	5.6	ns		
t <sub>PHL</sub>		1.5		1	4.6	113	

<sup>†</sup> Slow (ERC = H) and Fast (ERC = L)

<sup>&</sup>lt;sup>‡</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



# SN74GTLP2033

# 8-BIT LVTTL-TO-GTLP ADJUSTABLE-EDGE-RATE REGISTERED TRANSCEIVER WITH SPLIT LVTTL PORT AND FEEDBACK PATH

SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $V_{TT} = 1.5 \text{ V}$ and $V_{REF} = 1 \text{ V}$ for GTLP (see Figure 1) (continued)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATET	MIN	TYP‡	MAX	UNIT	
<sup>t</sup> PLH	1.000004014	40		2.5	6.2	6.2		
t <sub>PHL</sub>	LOOPBACK	AO	-	2	5	5	ns	
t <sub>PLH</sub>	Al	40		1	5.6	5.6		
t <sub>PHL</sub>	(loopback high)	AO	-	1	5	5	ns	
	Dies ties Deserted outside (00	Slow		2.8				
t <sub>r</sub>	Rise time, B-port outputs (20	Rise time, B-port outputs (20% to 80%)				1.5		
	Rise time, AO (10% to 90%)				3.5			
	- H :	2( 4 . 000()	Slow	3				
t <sub>f</sub>	Fall time, B-port outputs (80°	Fall time, B-port outputs (80% to 20%)			1.8			
	Fall time, AO (90% to 10%)				1.5			

<sup>†</sup> Slow (ERC = H) and Fast (ERC = L)

# skew characteristics over recommended ranges of supply voltage and operating free-air temperature (see Figure 1)§

PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATET	MIN TYP‡	MAX	UNIT
t <sub>sk(LH)</sub> ¶	Al	В	Slow	0.5	1	20
t <sub>sk(HL)</sub> ¶	Al	В	Slow	0.5	1	ns
t <sub>sk(LH)</sub> ¶	Al	В	Fast	0.4	0.9	20
t <sub>sk(HL)</sub> ¶	Al	В	газі	0.4	0.9	ns
$t_{sk(LH)}^{\P}$	CLKAB/LEAB	В	Slow	0.5	1	ns
t <sub>sk(HL)</sub> ¶	CLNAD/LLAD	В	Slow	0.5	1	
t <sub>sk(LH)</sub> ¶	CLKAB/LEAB	В	Fast	0.4	0.9	ns
t <sub>sk(HL)</sub> ¶	CLNAD/LEAD	В	газі	0.4	0.9	115
	Al	В	Slow	1.4	2	
t <sub>sk(t)</sub> ¶	Al	В	Fast	0.6	1.4	ns
	CLKAB/LEAB	В	Slow	1.8	2.5	113
	OLIVAD/LLAD	5	Fast	0.9	1.8	

<sup>†</sup> Slow (ERC = L) and Fast (ERC = H)



<sup>‡</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

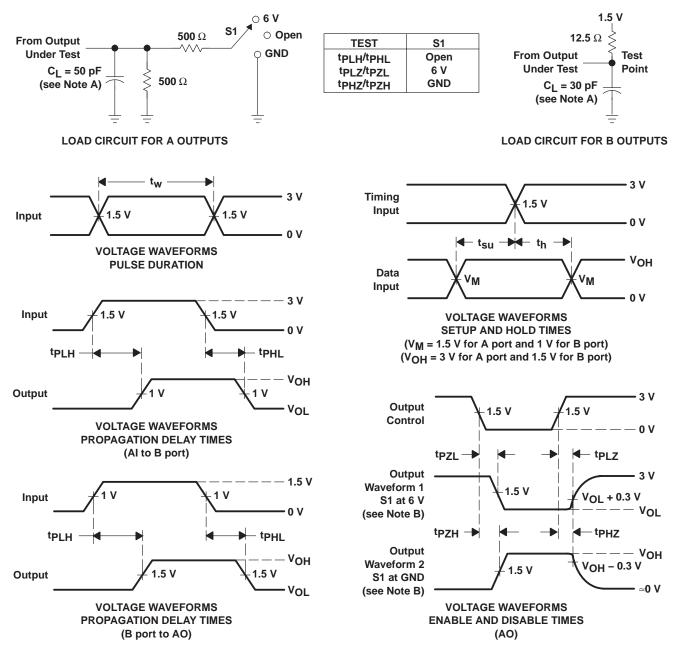
<sup>‡</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

<sup>§</sup> Actual skew values between the GTLP outputs could vary on the backplane due to the loading and impedance seen by the device.

<sup>¶</sup> t<sub>sk(LH)</sub>/t<sub>sk(HL)</sub> and t<sub>sk(t)</sub> – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs with the same packaged device. The specifications are given for specific worst-case V<sub>CC</sub> and temperature and apply to any outputs switching in the same direction either high to low [t<sub>sk(HL)</sub>] or low to high [t<sub>sk(LH)</sub>] or in opposite directions, both low to high and high to low [t<sub>sk(t)</sub>].

SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

#### PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\approx$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ ,  $t_f \approx$  2 ns.  $t_f \approx$  2 ns.
  - D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

#### DISTRIBUTED-LOAD BACKPLANE SWITCHING CHARACTERISTICS

The preceding switching characteristics table shows the switching characteristics of the device into a lumped load (Figure 1). However, the designer's backplane application is probably a distributed load. The physical representation is shown in Figure 2. This backplane, or distributed load, can be approximated closely to a resistor inductance capacitance (RLC) circuit, as shown in Figure 3. This device has been designed for optimum performance in this RLC circuit. The following switching characteristics table shows the switching characteristics of the device into the RLC load, to help the designer to better understand the performance of the GTLP device in this typical backplane. See www.ti.com/sc/gtlp for more information.

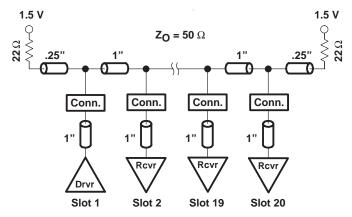


Figure 2. High-Drive Test Backplane

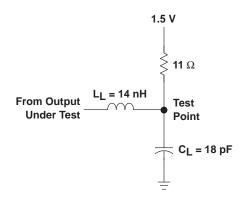


Figure 3. High-Drive RLC Network



# **SN74GTLP2033** 8-BIT LVTTL-TO-GTLP ADJUSTABLE-EDGE-RATE REGISTERED TRANSCEIVER WITH SPLIT LYTTL PORT AND FEEDBACK PATH SCES352C - JUNE 2001 - REVISED SEPTEMBER 2001

# switching characteristics over recommended operating conditions for the bus transceiver function (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	EDGE RATE†	түр‡	UNIT	
t <sub>PLH</sub>	Al		21	4.7		
t <sub>PHL</sub>	(buffer)	В	Slow	5	ns	
<sup>t</sup> PLH	Al		F	3.7		
<sup>t</sup> PHL	(buffer)	В	Fast	4	ns	
<sup>t</sup> PLH	LEAB	I D I		5.5		
<sup>t</sup> PHL	(latch mode)	В	Slow	5.8	ns	
<sup>t</sup> PLH	LEAB		Fort	4.6		
<sup>t</sup> PHL	(latch mode)	В	Fast	4.8	ns	
<sup>t</sup> PLH	CLKAB	<b>D</b>	Class	5.8		
<sup>t</sup> PHL	(flip-flop mode)	В	Slow	6	ns	
<sup>t</sup> PLH	CLKAB	В	Fast	4.9	20	
<sup>t</sup> PHL	(flip-flop mode)	D	rasi	4.9	ns	
<sup>t</sup> PLH	OMODE	В	Slow	5.5	20	
<sup>t</sup> PHL	OIMODE	В	Slow	5.7	ns	
t <sub>PLH</sub>	OMODE	В	Foot	4.5	20	
<sup>t</sup> PHL	OIMODE	D	Fast	4.7	ns	
	Rise time, B-port outputs (20	)0/ to 900/)	Slow	1.8	20	
t <sub>r</sub>	Rise time, b-port outputs (20	J70 (U 0U70)	Fast	1.1	ns	
4-	Fall time, B-port outputs (80°	2/ to 200/)	Slow	3.4	ns	
t <sub>f</sub>	raii time, b-port outputs (80°	70 (U 2U 70)	Fast	2.6	115	

<sup>†</sup> Slow (ERC = H) and Fast (ERC = L)

 $<sup>\</sup>ddagger$  All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C. All values are derived from TI-SPICE models.





com 27-Sep-2007

#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74GTLP2033DGGRE4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74GTLP2033DGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74GTLP2033DGVRE4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74GTLP2033DGVRG4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTLP2033DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTLP2033DGVR	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTLP2033GQLR	NRND	BGA MI CROSTA R JUNI OR	GQL	56	1000	TBD	SNPB	Level-1-240C-UNLIM
SN74GTLP2033ZQLR	ACTIVE	BGA MI CROSTA R JUNI OR	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

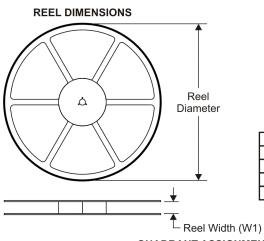
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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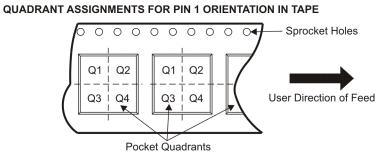
### TAPE AND REEL INFORMATION



# TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

— Reel viidii (vv i)



\*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74GTLP2033DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	15.8	1.8	12.0	24.0	Q1
SN74GTLP2033DGVR	TVSOP	DGV	48	2000	330.0	24.4	6.8	10.1	1.6	12.0	24.0	Q1
SN74GTLP2033GQLR	BGA MI CROSTA R JUNI OR	GQL	56	1000	330.0	16.4	4.8	7.3	1.45	8.0	16.0	Q1
SN74GTLP2033ZQLR	BGA MI CROSTA R JUNI OR	ZQL	56	1000	330.0	16.4	4.8	7.3	1.45	8.0	16.0	Q1





\*All dimensions are nominal

All difficultions are norminal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74GTLP2033DGGR	TSSOP	DGG	48	2000	346.0	346.0	41.0
SN74GTLP2033DGVR	TVSOP	DGV	48	2000	346.0	346.0	41.0
SN74GTLP2033GQLR	BGA MICROSTAR JUNIOR	GQL	56	1000	346.0	346.0	33.0
SN74GTLP2033ZQLR	BGA MICROSTAR JUNIOR	ZQL	56	1000	346.0	346.0	33.0

# ZQL (R-PBGA-N56)

# PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is lead-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).



# GQL (R-PBGA-N56)

# PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



## DGG (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

## DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

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